## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | YAMAGUCHI ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,772,038	08-2004	Kadono, Mitsuhiko	700/159
*	В	US-5,428,547	06-1995	Ikeda, Mutsumi	700/174
*	С	US-6,161,055	12-2000	Pryor, Timothy R.	700/175
*	D	US-4,789,931	12-1988	Kuragano et al.	700/176
*	E	US-6,591,156	07-2003	Fukaya et al.	700/159
*	F	US-6,643,560	11-2003	Shimomura, Katsunori	700/160
*	G	US-5,815,400	09-1998	Hirai et al.	700/173
*	Н	US-5,191,538	03-1993	Yoneda et al.	700/174
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10034496 A	02-1998	Japan	SAKAE et al.	B23Q 15/00
	0	JP 11165239 A	06-1999	Japan	TAWARA et al.	B23Q 15/00
	Р	JP 11175124 A	07-1999	Japan	HAGIYAMA et al.	G05B 19/4097
	a					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	٧							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.